

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/658,347	FUJIEDA, KENICHIRO	
Examiner	Art Unit	
Gerald B. Klebe	3618	

	SEARCHED					
Class	Subclass	Date	Examiner			
180	68.4 68.6 68.5 271 274	1 JUNOS	LIBN			
296	187.09 187.04					
296 B60R	21/34					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

(INCLUDING SEARCH	(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
DASE SCARCHON SELECTED REFERENCES OF APPLICANT'S IDS; TEXT SCANCH BASEDON KLYWONDS IN CLUDING RADIATOR MOUNTING, SUPPORT, DEFURNA SHOCK ABSURBING. REFERLT O PART SCARCH HISTORY FOR DOTTHICS	1JW05	MBZ			
SHOCK ABSURBING. REFUNTO PAST SCARCH HISTONY FOR DOTAILS					
CL 180 DKT II SEARCH BY PLI DU CL 286 SEARCH BY PRÌ. PC-ODER. TPC SEMICH BY PRÌ. ILAN.		·			
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